

A Pulse-Pattern Generator Using LabVIEW FPGA

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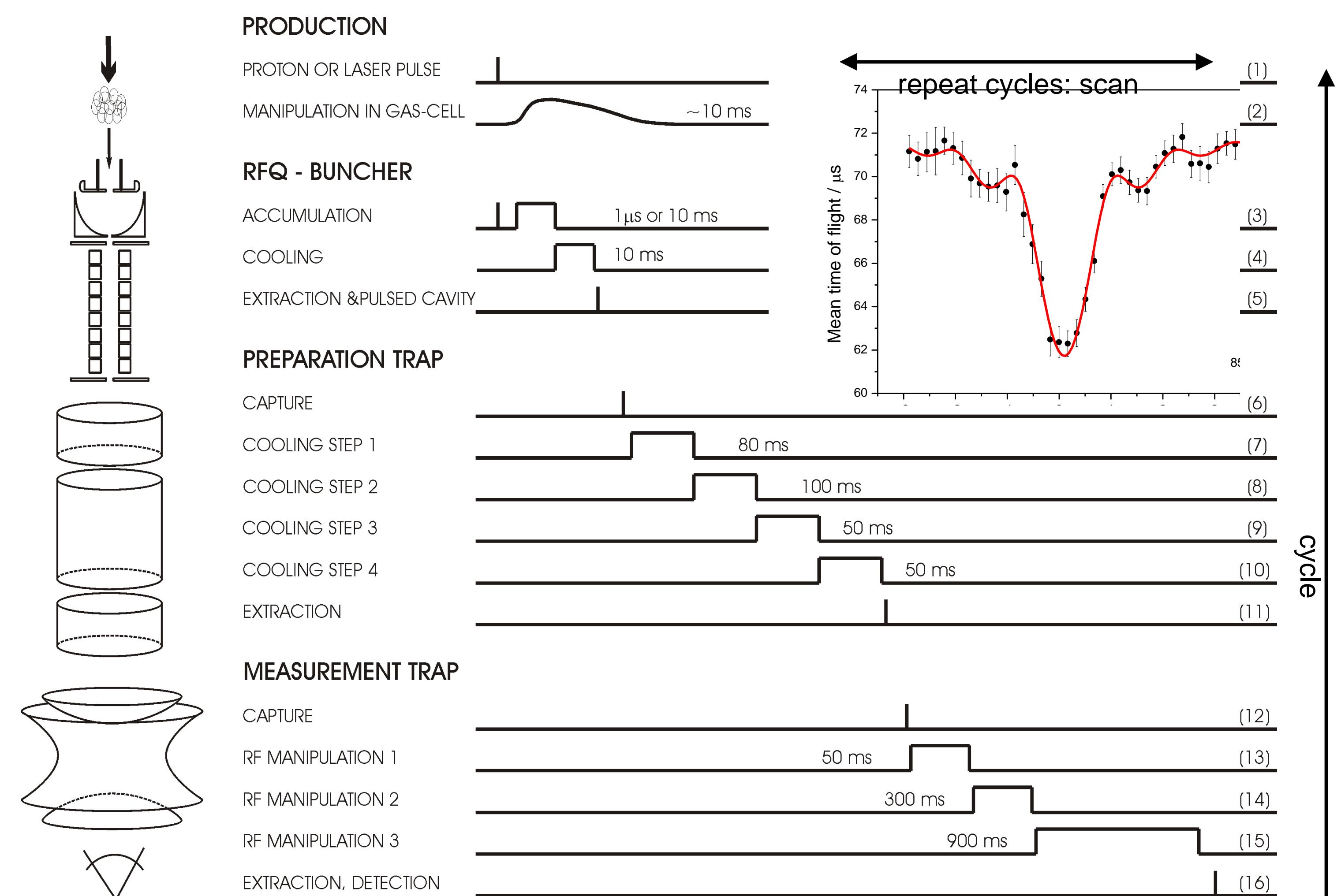
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Motivation

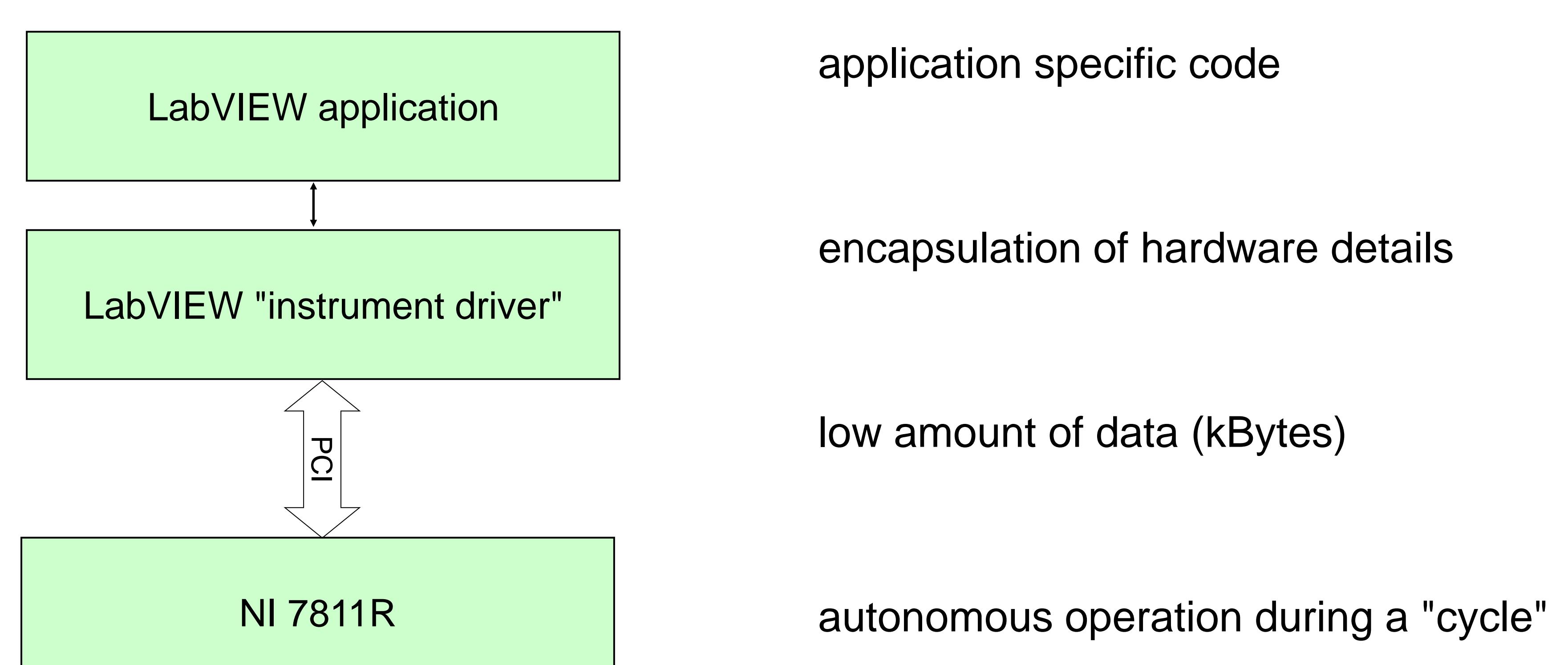
Timing system for small (~10 m) ion trap facilities



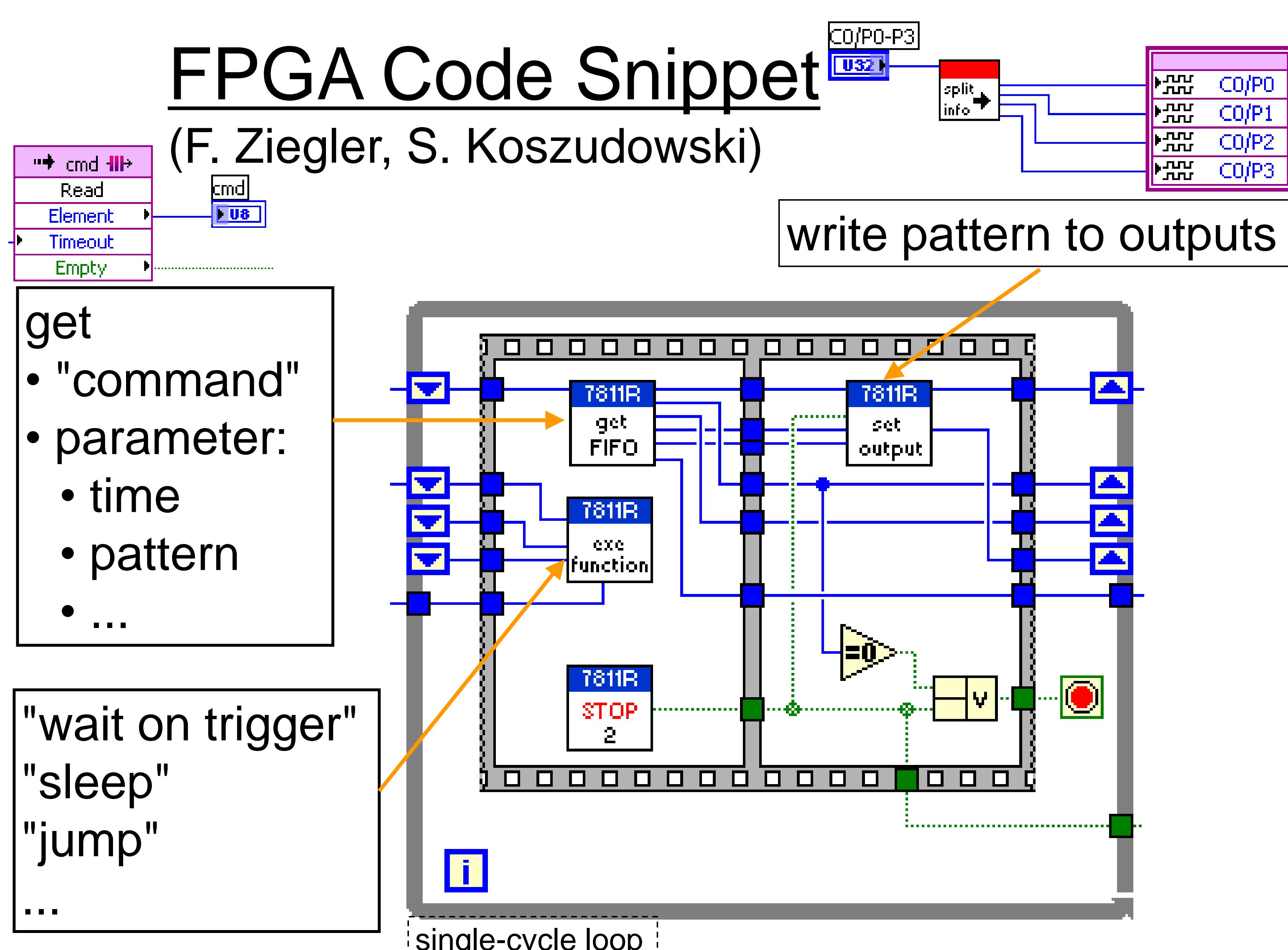
- synchronization to external trigger conditions
- synchronize/adjust steps with 10ns precision
- pattern width 64 bit, each bit is one output line
- pattern is applied for a specified time
 - 10000000 @ t = 0 μs
 - 10000001 @ t = 1.2 μs
 - 11000101 @ t = 235246.875 μs
 -
- more requirements: loops, *fast context switching* ...

Implementation

- PCI/PXI-7811R board from National Instruments ($\approx 1500,-$ €)
- 160 digital lines (TTL)
- Virtex II, 1 M gates
- 80 MHz single-cycle loop (12.5ns resolution)
- timing of bit patterns independent of
 - operating system
 - data-bus
 - PC, CPU,
- can be programmed by FPGA non-experts using LabVIEW
- then: VHDL code generation, Xilinx tool chain, ...

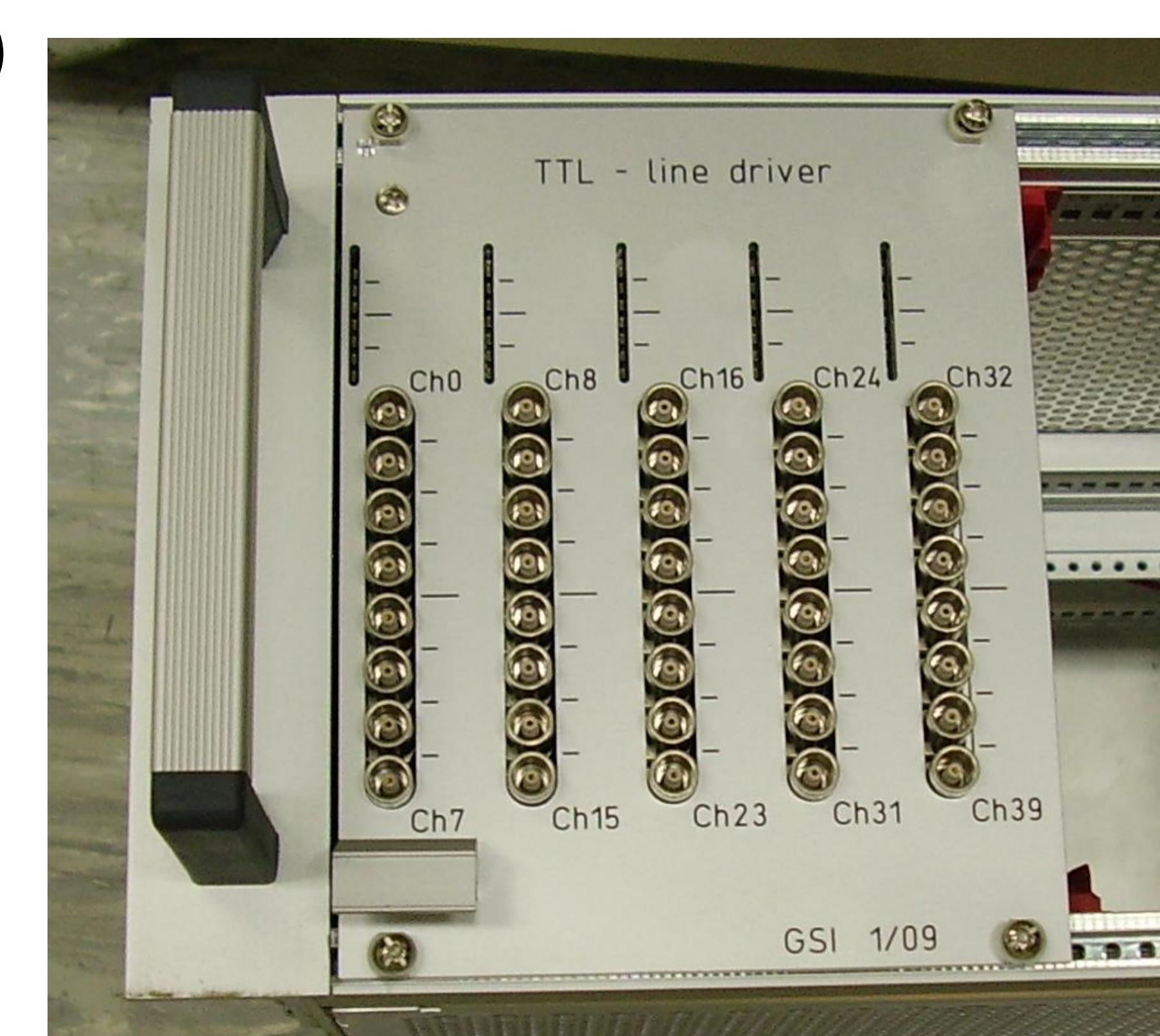


Procedure: Commands with user defined pattern data are uploaded to onboard memory. Pattern



Status and Remarks

- presently (2009) used at six experiments*
- FPGA compile time about 50 minutes (PIV, 3GHz)
- code also runs on other FPGA cards 7813, 7831, 7833, PCI/PXI
 - requires re-compilation of FPGA code
 - requires modification of LabVIEW code (just a typedef, but ...)
- PCI: no synchronization to external reference clock
- PXI: phase-locked to 10 MHz PXI clock
- NI boards provide TTL output @ 4 mA on high density plugs
 - some devices need more current at trigger inputs
 - users connect one TTL output to multiple trigger inputs
 - users want Lemo plugs!
- solution: signal conditioning using a TTL line-driver module (see picture)



References

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